		Application/Control No. 09/359,599	Applicant(s)/Patent Under Reexamination HOGG, TAD

Notice of References Cited

Examiner Fred Ferris	Art Unit 2123	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,304,639	10-2001	Malomsoky et al.	379/112.04
*	B	US-5,966,140	10-1999	Popovic et al.	345/441
*	C	US-6,334,125	12-2001	Johnson et al.	707/3
*	D	US-2003/0014379 A1	01-2003	SAIAS et al.	706/45
*	E	US-5,764,740	06-1998	Holender, Wlodek	379/112.05
*	F	US-5,727,051	03-1998	Holender, Wlodek	379/112.05
*	G	US-5,872,918	02-1999	Malomsoky et al.	709/220
*	H	US-5,703,792	12-1997	Chapman, David	702/27
*	I	US-6,198,412	03-2001	Goyal, Vivek K.	341/50
	J	US-6,564,197	05-2003	Sahami et al.	706/55
	K	US-5,895,470	04-1999	Pirolli et al.	707/102
	L	US-6,285,995	09-2001	Abdel-Mottaleb et al.	707/3
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	"A Library for Visualizing Combinatorial Structures", M. Najork, pp. 164-171, IEEE 1070-2385/94, IEEE 1994
*	V	"The Combinatorial Structure of Fuzzy Functional Dependencies", A. C. Sali, pp. 239-243, IEEE 0-7803-3627-5/97, IEEE May 1997
*	W	"A Combinatorial, Strongly Polynomial-time Algorithm for Minimizing Submodular Functions", S. Iwata, STOC 2000, ACM 1-58133-184-4/00/5, 1999
*	X	"Extracting Randomness: How and Why A Survey", N. Nisan, IEEE 0-8186-7386-9/96, IEEE 1996

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	"On the Average Delay for Routing Subject to Independent Deflections", B. Hajek, IEEE Trans. on Info. Theory, vol 39, No. 1, January 1993
*	V	"Voronoi Diagrams - A Survay of a Fundamental Geometric Data Strucutre", F. Aurenhammer, ACM Computing Surveys, Vol. 23, No. 3, September 1991 ✓
	W	"SONIA: A Service for Organizing Networked Information Autonomously", M. Sahami, ACM 0-89791-965-3/98/6, ACM 1998 ✓
	X	"Analysis and Design of Server Informative WWW-sites" A. M. Zarkesh, CIKM 97', ACM 0-89791-970, ACM 1997 ✓

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

	Notice of References Cited	Application/Control No. 09/359,599	Applicant(s)/Patent Under Reexamination HOGG, TAD	
		Examiner Fred Ferris	Art Unit 2123	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Robust self-assembly using highly designable structures", T. Hogg, Nanotechnology 10, IOP Publishing, January 1999
	V	"Better Than The Best: The Power of Cooperation", T. Hogg, 1992 Lectures in Complex Systems, pp. 165-184, Addison-Wesle 1993.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.